## Notice of References Cited Application/Control No. 10/521,490 Examiner Janelle N. Young Applicant(s)/Patent Under Reexamination SAITOU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,542,106	07-1996	Krenz et al.	455/575.7
*	В	US-5,649,306	07-1997	Vannatta et al.	455/575.7
*	С	US-6,456,247	09-2002	Hulick et al.	343/702
*	D	US-2003/0148784	08-2003	Sawamura et al.	455/550
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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